Notice of References Cited

Application/Control No.	Applicant(s)/Pater	nt Under
10/764,569	Reexamination MOTOYAMA ET	AL.
Examiner	Art Unit	
HIEU T. HOANG	2152	Page 1 of 1

U.S. PATENT DOCUMENTS

	U.S. I ATENT DOCUMENTO				
*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0221026	11-2004	Dorland, Chia-Chu S.	709/223
*	В	US-2004/0030768	02-2004	Krishnamoorthy et al.	709/223
*	С	US-7,069,480	06-2006	Lovy et al.	714/57
*	D	US-7,082,608	07-2006	Wilson et al.	719/315
*	Е	US-6,636,981	10-2003	Barnett et al.	714/4
*	F	US-7,316,022	01-2008	Nishio, Masahiro	719/321
*	G	US-5,504,921	04-1996	Dev et al.	709/223
*	Н	US-2005/0086368	04-2005	Winter, Robert L.	709/239
*	T	US-6,539,425	03-2003	Stevens et al.	709/220
*	J	US-2002/0004828	01-2002	Davis et al.	709/223
*	к	US-2003/0097425	05-2003	Chen, Weihai	709/220
*	L	US-2004/0153536	08-2004	Strassner, John	709/223
	м	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р					
	Q					
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	s					
	т					

NON DATENT DOCUMENTS

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